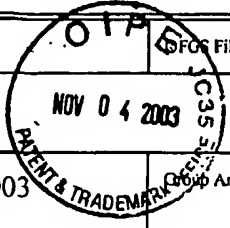
		Application 10/660,823		OFGS File No P/4338-6			
		Applicant John Mahdessian					
		Filing Date September 12, 2003		Group Art Unit 1751			
U.S. PATENT DOCUMENTS							
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate	
<i>LM</i>	US-4,956,021	09-1990	KERZE	—	—		
	US-5,891,197	04/1999	YOUNG ET AL.	—	—		
	US-6,243,969 B1	06-2001	YEAZELL	—	—		
	US-6,514,924 B1	02-2003	VAN HAUWERMEIREN ET AL.	—	—		
	US-2001/0022007 A1	09-2001	YEAZELL	—	—		
	US-2002/0078510 A1	06-2002	LEE	—	—		
	US-2003/0008799 A1	01-2003	BARNABAS ET AL.	—	—		
	US-2003/0060396 A1	03-2003	DEAK ET AL.	—	—		
✓	US-2003/0087781 A1	05-2003	VAN HAUWERMEIREN ET AL.	—	—		
	US-						
FOREIGN PATENT DOCUMENTS							
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
Examiner <i>LM</i>		Date Considered <i>9-24-04</i>					
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							

APPLICANT'S ART CITATION (Use several sheets if necessary)			Application 10/660,823		SFOP File No P/4338-6		
			Applicant John Mahdessian				
			Filing Date September 12, 2003				
U.S. PATENT DOCUMENTS							
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	US-4,956,021	09-1990	KERZE				
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	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
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Examiner			Date Considered				
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